Photocarrier generation from interlayer charge-transfer transitions in WS$_2$-graphene heterostructures

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Efficient interfacial carrier generation in van der Waals heterostructures is critical for their electronic and optoelectronic applications. We demonstrate broadband photocarrier generation in WS$_2$-graphene heterostructures by imaging interlayer coupling–dependent charge generation using ultrafast transient absorption microscopy. Interlayer charge-transfer (CT) transitions and hot carrier injection from graphene allow carrier generation by excitation as low as 0.8 eV below the WS$_2$ bandgap. The experimentally determined interlayer CT transition energies are consistent with those predicted from the first-principles band structure calculation. CT interactions also lead to additional carrier generation in the visible spectral range in the heterostructures compared to that in the single-layer WS$_2$ alone. The lifetime of the charge-separated states is measured to be ~1 ps. These results suggest that interlayer interactions make graphene–two-dimensional semiconductor heterostructures very attractive for photovoltaic and photodetector applications because of the combined benefits of high carrier mobility and enhanced broadband photocarrier generation.

INTRODUCTION

Nanostructured materials hold great promise as building blocks to create new architectures for electronic and optoelectronic devices. Atomically thin van der Waals layers (1) represent a new two-dimensional (2D) material class with unusual optical and electronic properties emerging at the single- or few-layer limit (2–7), which provide opportunities to design new functionalities. Specifically, heterostructures can be formed by artificially stacking layers of different 2D materials, because traditional restrictions in heterostructure growth such as lattice-matching conditions and atom interdiffusion are no longer required (8–11). In the past few years, heterostructures constructed from graphene, hexagonal boron nitride, and semiconductor transition metal dichalcogenides (TMDCs) have established a remarkable platform for photovoltaic applications, including photodetectors, light-emitting diodes, and atomically thin photovoltaics (9, 12–20).

Efficient photocarrier generation at the interfaces remains a central challenge for many of the abovementioned applications of 2D heterostructures. The structural tunability of 2D nanostructures along with atomically thin and sharp 2D interfaces provides new opportunities for controlling charge-transfer (CT) interactions at the interfaces (21, 22). Charge transfer at 2D interfaces has been demonstrated to be very rapid, occurring on time scales ranging from 50 fs to a few picoseconds (23–29), and interlayer CT excitation transitions have been observed (30, 31). Graphene is a versatile component to couple to TMDCs because of its high carrier mobility in combination with chemical inertness, high thermal conductance, and extraordinary stability. Heterostructures constructed from graphene and TMDCs also provide opportunities to achieve broadband charge separation below the semiconductor bandgap by using hot carrier injection from graphene (32). These heterostructures maintain the high mobility of graphene, which suggests that efficient extraction of carriers can be achieved at the interfaces (20, 33, 34).

A largely unexplored question is how interlayer CT interactions contribute to interfacial charge generation and separation in 2D heterostructures. Charge separation could take place directly by exciting CT transitions at the interface. Because the interlayer distance between the graphene layer and the 2D semiconductor layer could be as small as 3 Å, interlayer interactions beyond London dispersion are apparent, leading to modification of optical absorption and band structures (34–38). In addition, because practically every atom is on the surface, interfacial charge transfer is expected to play a much more important role in 2D heterostructures than in those formed by bulk materials. Although emission from interlayer CT excitons has been observed in 2D heterostructures (30, 31), no direct excitation of these CT states has been reported partly due to relatively weak oscillator strengths (39). Here, we present a joint experimental and theoretical investigation to address charge generation from interlayer CT transitions in TMDC/graphene heterostructures. We use spatial ultrafast transient absorption microscopy (TAM) to directly compare charge generation at different interlayer coupling strengths to elucidate the role of CT transitions in WS$_2$–graphene heterostructures. These results demonstrate effective broadband carrier generation by excitations below the bandgap in TMDC/graphene heterostructures.

RESULTS AND DISCUSSION

Interlayer coupling–dependent charge transfer from WS$_2$ to graphene

The top and side views of heterostructures formed by a WS$_2$ layer and a graphene layer are schematically depicted in Fig. 1A. The optical micrograph of a heterostructure constructed from an exfoliated bilayer WS$_2$ (2L–WS$_2$) flake and a chemical vapor deposition (CVD)–grown graphene (G) layer on a Si/SiO$_2$ substrate is shown in Fig. 1B. From the atomic force microscopy (AFM) image (Fig. 1C), significant spatial heterogeneity in the contact between the 2L–WS$_2$ layer and the graphene layer can be observed, which is common for heterostructures fabricated by transfer methods. Specifically, there is an area with very flat morphology (area 1), whereas another area has many ripples (area 2), which indicates good contact between the graphene layer and the WS$_2$.
layer in area 1 and poor contact in area 2. The difference in contact can also be seen by the AFM line scans from areas 1 and 2, as shown in fig. S1.

The inherent spatial heterogeneity as imaged in Fig. 1C presents a major difficulty in elucidating interfacial CT dynamics in relation to interlayer coupling (40). To circumvent this difficulty, we use TAM with high spatial and temporal resolutions to image how interlayer coupling affects the dynamics of charge transfer from WS2 to graphene. We first excite WS2 at 3.14 eV and probe the A-exciton bleach at 1.99 eV to investigate charge transfer from WS2 to graphene. A pump fluence of ~2 μJ cm⁻² corresponds to an exciton density of ~3.6 × 10¹¹ cm⁻² in 1L-WS2 (~7.2 × 10¹¹ cm⁻² in 2L-WS2). To construct an image, pump-induced change in probe reflection ΔR is plotted as a function of the sample position. The spatial resolution of TAM is ~400 nm, as detailed in figs. S2 and S3. Note that the graphene-only regions of the samples have no detectable signal under the experimental conditions because of a lower absorption coefficient compared to WS2.

The TAM image at 0 ps for the 2L-WS2/G heterostructure is shown in Fig. 1D. As expected, better interlayer contact leads to faster charge transfer from WS2 to graphene. The exciton decay at the strong-coupling area 1 can be fitted with a single exponential function with a decay constant of 3.0 ± 0.1 ps (Fig. 1E), similar to what has been reported previously (24). On the other hand, the weak-coupling area 2 shows a much slower biexponential exciton decay, with a fast component of 3.8 ± 0.3 ps (55%) and a slow component of 71.3 ± 3.0 ps (45%) (Fig. 1E). The slow decay component observed for area 2 is very similar to that from a control 2L-WS2 flake, consistent with poor contact hampering charge transfer from WS2 to graphene. The control 2L-WS2 is also imaged as shown in fig. S4A, and no spatial heterogeneity is observed in exciton dynamics.

The TAM image for the 1L-WS2/G heterostructure is shown in Fig. 1F. Similar spatial heterogeneity in dynamics is also observed in the 1L-WS2/G heterostructure. Charge transfer at a strong-coupling location of the 1L-WS2/G heterostructure has a characteristic time of 1.4 ± 0.1 ps (Fig. 1G), demonstrating an even stronger coupling between graphene and the 1L-WS2 layer than in the 2L-WS2/G heterostructure. The CT time from 1L-WS2 to graphene is consistent with previous reports (24, 29).

**Carrier generation by excitation below WS2 bandgap**

We perform measurements with pump photon energies below the WS2 bandgap, where only the interlayer CT transitions and graphene can be excited. Figure 2A plots the TA signal intensity at 0 ps probed at the A-exciton resonance (1.99 eV) in the 1L-WS2/G heterostructure and a control 1L-WS2 when varying the pump photon energy from 1.2 to 1.8 eV (bandgap of WS2 is ~2 eV) with a pulse spectral width of ~20 meV. No detectable TA signal above the noise level is observed for the control 1L-WS2 layer with pump energy lower than 1.8 eV. In contrast, both heterostructures show TA spectra that track the WS2 A-exciton resonance with pump energy of 1.57 eV (Fig. 2B). The TA signal intensity is strongly dependent on the interlayer coupling. Figure 2C illustrates TAM images at a 0-πs time delay with 1.57-eV pump photon energy for the same 2L-WS2/G heterostructure as shown in Fig. 1D. The TA signal intensity is always higher at the strong-coupling area 1 than at the weak-coupling area 2. The overall patterns observed by TAM imaging with the 1.57-eV pump photon energy (Fig. 2C) are similar to those with the 3.14-eV pump photon energy as shown in Fig. 1D. ΔR scales linearly as a function of pump fluence, implying that the observed TA signals are due to linear absorption rather than to nonlinear two-photon excitation (Fig. 2D).
There are two possible mechanisms (illustrated in Fig. 2E) that could lead to the bleaching of A exciton by excitation below the WS$_2$ bandgap. One possibility is that the photon is absorbed by the graphene layer and hot carriers are subsequently transferred from graphene to WS$_2$ (mechanism 1, only electron pathway is shown) (32). Similar mechanism has led to the generation of photocurrent with excitations below the bandgap in graphene/WSe$_2$ heterostructures, as reported by Massicotte et al. (32). The absorption by graphene is due to interband transitions, creating photoexcited electrons and holes with energy $E = E_{\text{photon}}$, with respect to the Dirac point of graphene ($E_{\text{photon}}$ is the incident photon energy). Carrier-carrier scattering establishes a quasi-equilibrium distribution in ~30 fs with an elevated effective electron temperature $T_e$ (41). For hot electron injection, the Schottky barrier is equal to $\Phi_B = (E_{\text{CBM}} - E_D)$, where $E_D$ is the Dirac point of the graphene layer and $E_{\text{CBM}}$ is the conduction band minimum (CBM) of WS$_2$ (42, 43). $\Phi_B$ can vary depending on the doping level of the two layers and the substrate. The hot electrons with energy larger than the barrier height $\Phi_B$ can be injected into the WS$_2$ layer. The number of electrons with sufficient energy is given by the Boltzmann distribution and scales with $e^{-\frac{E_{\text{photon}}}{k_B T_D}}$, where $k_B$ is the Boltzmann constant (32). Similar process also exists for the holes. The other possible mechanism is through direct excitation of interlayer CT transitions (mechanism 2). (F) Normalized transient dynamics of the 1L-WS$_2$/G heterostructure at area 3 and the 2L-WS$_2$/G heterostructure at area 1. Pump photon energy is 1.57 eV and probe photon energy is 1.99 eV. Solid lines are fits with a single exponential decay function convoluted with the experimental response function.

Fig. 2. Carrier generation by excitations below the WS$_2$ bandgap. (A) TA signal at 0 ps probed at 1.99 eV (A-exciton resonance) for the 1L-WS$_2$/G heterostructure when varying the pump photon energy from 1.2 to 1.8 eV (pump fluence, ~2 µJ cm$^{-2}$). (B) TA spectrum of the A-exciton resonance in the 1L-WS$_2$/G and 2L-WS$_2$/G heterostructures, and the control 1L-WS$_2$ at a 0-ps time delay with pump photon energy of 1.57 eV and pump fluence of ~17 µJ cm$^{-2}$. (C) TAM image of the 2L-WS$_2$/G heterostructure at 0 ps (pump, 1.57 eV; probe, 1.99 eV; pump fluence, ~17 µJ cm$^{-2}$). Scale bar, 1 µm. (D) Amplitude of the TA signal at a 0-ps time delay versus pump fluence for the 1L-WS$_2$/G heterostructure at area 3 showing a linear dependence at three different pump photon energies (probe, 1.99 eV). (E) Schematic showing two possible mechanisms. One possibility is that the graphene layer is excited and hot carrier is subsequently transferred from graphene to WS$_2$ (mechanism 1), and the other possibility is the direct excitation of interlayer CT transitions (mechanism 2).
of graphene and WS₂ needs to be taken into account and the transition energies will be discussed in the following section.

Both hot carrier injection and direct CT absorption mechanisms can lead to a charge-separated state, where the electron (hole) resides in the WS₂ and the hole (electron) remains on the graphene layer. Consequently, the bleaching of A-exciton transition results from Pauli blocking and/or bandgap renormalization in WS₂ (44). The dynamics of charge generation and recombination has been measured following the 1.57-eV pump excitation (Fig. 2F). For mechanism 1, a risetime is expected corresponding to hot carrier transfer from graphene. In contrast, direct excitation of the CT transitions should lead to an instantaneous rise of the TA signal. The TA signal rise is instantaneous within a pulse width of ~300 fs for both the 1L-WS₂/G and 2L-WS₂/G heterostructures (Fig. 2F), probably due to the fact that the time resolution of our experiments is not sufficient to resolve hot carrier injection from graphene. In the 1L-WS₂/G heterostructure, the recombination of the electrons and holes at the interface is 0.78 ± 0.04 ps, which is shorter than that of 1.30 ± 0.03 ps in the 2L-WS₂/G heterostructure. The faster recombination in the 1L-WS₂/G heterostructure suggests that the interfacial charge-separated states are dependent on the detailed electronic coupling at interfaces (21). The interfacial electron-hole interaction strength decreases as the thickness of TMDC increases, because the additional layers screen the interaction (45, 46).

For the charge-separated states, the spatial indirect nature (that is, electrons and holes reside in different layers) should dictate the recombination process. The indirect intralayer exciton band structure of 2L-WS₂ probably does not play an important role in determining the lifetime of interfacial charge recombination.

Both mechanisms illustrated in Fig. 2E could contribute to the TA signal; however, it is highly challenging to separate these two contributions. In principle, although linear absorption could directly measure the CT transitions from mechanism 2, this is a difficult task because of the weak oscillator strengths (47). For instance, the interlayer exciton oscillator strength in MoSe₂/WSe₂ heterostructures is at least 20 times weaker than that in the intralayer exciton (39). To separate the contribution from the two mechanisms, we examined the pump fluence dependence when excited below the WS₂ bandgap. As demonstrated by Massicotte et al. (32), the photocurrent exhibits a $P_B^\alpha$ ($\alpha > 1$) dependence on the pump fluence due to the hot carrier injection contribution when excited below the bandgap of WSe₂, which can be explained by the fact that the number of electrons with sufficient energy scales with $e^{-\Delta E/kT}$. In contrast, direct absorption by WSe₂ above the bandgap leads to a linear power dependence ($\alpha = 1$) (32). As shown in Fig. 2D, a linear dependence (that is, $\Delta R \propto P$, $\alpha = 1$) is observed for excitations at 1.30, 1.60, and 1.80 eV in the 1L-WS₂/G heterostructure, which could not be explained by hot carrier injection from graphene. A linear pump fluence dependence is also observed for the 2L-WS₂/G heterostructure when excited at 1.57 eV (fig S5). On the other hand, direct CT absorption (mechanism 2) should lead to the linear power dependence similar to the absorption by WS₂ above the bandgap. Therefore, we conclude that direct CT absorption also contributes to the observed TA signal in the 1L-WS₂/G and 2L-WS₂/G heterostructures when excited below the WS₂ bandgap. We note that the WSe₂ in the graphene/WSe₂ heterostructures studied by Massicotte et al. (32) are multilayer (3 to more than 100 layers), and the contribution from intralayer CT absorption to the photocurrent should be much weaker than in the heterostructures based on the 1L-WS₂ investigated here. This is because the oscillator strength of the CT transitions decreases as the thickness of the TMDC increases, as the additional layers screen the electron-hole interaction in the CT states (45, 46). The decreased exciton oscillator strength as the dielectric constant increases has been observed in single-walled carbon nanotubes (45).

**First-principles calculation of interlayer CT transitions**

To identify possible interlayer CT transitions, we performed band structure calculation for the 1L-WS₂/G heterostructure from first principles using density functional theory (DFT). We considered two models, the commensurate and incommensurate. In the first model, we take a 4 × 4 WS₂ and a 5 × 5 graphene supercell, because the lattice vectors of these two cells have a mismatch of only 2.3%. We then average both lattice vectors so that 4 × 4 WS₂ and 5 × 5 graphene supercell sizes match exactly. This results in small stretching of the WS₂ monolayer and compression of the graphene layer. The corresponding band structure (Fig. 3A) is an almost perfect superposition of the two individual band structures of graphene and WS₂, that is, the band edges of both systems are kept almost unaffected by one another, and we can determine the band shift of the WS₂ with respect to graphene: Conduction band of WS₂ is situated at about 1 eV above the Dirac point of graphene. Note that the Dirac point might not be the most precise in the present context, because there is a small band gap (~11 meV) opening in the heterostructure.

Because the lattices in the actual heterostructures are not aligned, we next consider an incommensurate model to account for a large lattice mismatch of ~22% (lattice constant of graphene is 2.46 Å and that of WS₂ is 3.15 Å). Although this first-principles calculation is not computationally feasible at present, we calculated the separate perfect monolayers and plotted their band structure as an overlap, with the shift of the band edges calculated in the previous step. The result for the Γ-K direction is shown in Fig. 3B. Because of the lattice mismatch, the Brillouin zones are also shifted with respect to each other. Therefore, the K points do not overlap in every cell, in contrast to the commensurate model. As shown in Fig. 3B, additional interlayer excitations exist in the incommensurate lattices, which allow the excited electrons from graphene to WS₂, or holes from WS₂ to graphene that could enhance carrier generation. However, the interlayer excitations are not observed for the other direction along the Γ-M path (see fig. S6).

The interlayer CT transitions below the bandgap of WS₂ are identified in Fig. 3B. There is a transition of electron from the K point of graphene to the K point of WS₂ at 1.04 eV, a transition from the K point of graphene to the conduction band of WS₂ near the Γ point with an energy of 1.22 eV, and a transition at 1.54 eV from the K point of graphene to between the Γ and K point of WS₂. Note that inherent errors of DFT neglect exciton binding energy and may introduce a constant energy shift of the conduction band. According to high-level calculations on a single-layer WS₂, the error in predicting the transition energies should be no more than 0.5 eV (48). In addition, the graphene layer is p-doped with a Fermi level shifted by ~0.17 eV, as determined by Raman spectroscopy (fig S7). Taking these two effects into account, the predicted transition energies are consistent with the absorption band of 1.2 to 1.8 eV, as shown in Fig. 2A. On the basis of the agreement, we assign the interlayer transitions observed to electrons from the valence bands of graphene that are promoted to the conduction bands of WS₂. We cannot entirely rule out the transitions prompting holes from WS₂ to graphene, and they probably also contribute. Note that our model in Fig. 3B is incomplete, and it reflects only one WS₂/graphene rotation angle (with matching lattice orientations). Therefore, the intensities of the interlayer excitations may be dependent on the mutual rotation of
However, the CT transition energies should still fall within the same range of 1 to 2 eV regardless of the rotation angle, because the band structure of the heterostructure is almost perfectly the superposition of that of graphene and WS$_2$. Further, because of a large lattice mismatch of ~22% and the polycrystalline nature of the CVD graphene, many rotation angles likely coexist in the heterostructures measured experimentally. Therefore, the measured CT transition energies are probably the average of many rotation angles. The interlayer CT transition energies can be potentially modulated by tuning the Fermi level of graphene, which will be addressed in future studies.

Enhanced carrier generation by excitation above the bandgap

With excitation above the WS$_2$ bandgap at 3.14 eV, TA signal intensities at 0 ps for the strong-coupling areas are higher than those for the weak-coupling areas. The TA intensity for the 1L-WS$_2$/G heterostructure is enhanced by a factor of 4 over the control, as shown in Fig. 4A. The TA intensity at the strong-coupling area 1 in the 2L-WS$_2$/G heterostructure is about two times higher than the control, whereas the weak-coupling area 2 has a TA amplitude similar to that of the control (Fig. 4B). A higher TA intensity correlated with stronger interlayer coupling implies that the nature of the photoexcited state in WS$_2$ is dependent on the interlayer coupling strength. A control 2L-WS$_2$ is also imaged as shown in fig. S4, and no spatial heterogeneity is observed in the TA signal intensity (the SDs of $\Delta R$ at 0 and 5 ps are 3.4% and 3.8%, respectively). Raman intensity from the heterostructures is also enhanced over the control (fig. S8). We note here that the enhanced TA signal in the WS$_2$/G heterostructure has been observed previously (24); however, no explanation has been given.

Because the TA signal results from combined Pauli blocking and bandgap renormalization effects (44, 49), there are two possible reasons for the increased TA intensities at strong-coupling locations: (i) The absorption above the bandgap is increased by the interlayer CT transitions and an increased TA intensity is due to Pauli blocking and (ii) photoexcitation of CT transitions leads to larger bandgap renormalization effects than excitons. Note that transient bandgap renormalization observed here is due to further modifications of the exciton energy upon photoexcitation beyond the static effect (49, 50). To directly measure the interlayer coupling–dependent absorption at 3.14 eV, we imaged correlated reflection and transmission of 1L-WS$_2$/G on a transparent sapphire substrate (fig. S9). The linear absorption is deduced using approaches described in Materials and Methods. The linear absorption and correlated TAM image are shown in Fig. 4 (C and D). Both linear absorption and transient absorption are increased at a strong-coupling location. Having graphene on top leads to static bandgap renormalization of WS$_2$ and reduces the exciton binding energy (51, 52). It is possible that
the increased linear absorption is due to static screening from graphene that modifies the absorption of WS$_2$ instead of the absorption by the CT transitions. However, the absorption at 3.14 eV is not near any exciton resonances, and therefore, the change in the absorption due to static screening from graphene should not be significant. Although linear absorption increased by ~25% at a strong-coupling location compared to a weak-coupling location (Fig. 4C), the TA signal intensity at the same location is increased by ~70% (Fig. 4D), indicating that the increased absorption accounts partially for the increased TA intensity. The linear absorption and the TA images do not look exactly the same, probably due to the higher spatial resolution of TAM being a two-photon technique (53) or interlayer (WS$_2$ and graphene) orientation.

An additional TA signal increase at strong-coupling locations is likely due to a larger transient bandgap renormalization effect induced by the photoexcited CT states. The TA spectrum at the strong-coupling location in 1L-WS$_2$/G has a derivative shape with a new red-shifted photoinduced absorption band, in contrast to the control 1L-WS$_2$ (Fig. 4A). The derivative-shaped TA spectrum is a signature of transient bandgap renormalization because of the screening of excitons by photo-generated carriers or excitons (44). The transient reduction of the optical bandgap is estimated by taking the energy difference between the positive peak and the negative peak to be ~30 meV for the 1L-WS$_2$/G heterostructure, as shown in Fig. 4A. Similar transient bandgap renormalization has also been observed for another 1L-WS$_2$/G heterostructure on a sapphire substrate (fig. S10). To verify that the transient bandgap renormalization effects observed are not just due to a higher exciton density, we measured the TA spectrum of 1L-WS$_2$ at an exciton density from 7.2 × 10$^{11}$ cm$^{-2}$ to 2.9 × 10$^{12}$ cm$^{-2}$ (see fig. S11). Even at a higher exciton density (eight times) than that in the measurements of Fig. 4A, no obvious transient bandgap renormalization has been observed. We note that Sie et al. (50) reported the exciton red shift at an exciton density of as low as 10$^{11}$ cm$^{-2}$ under a similar nonresonant excitation condition, which is somewhat inconsistent with our results.

The larger transient bandgap renormalization effects at the strong-coupling locations could be explained by the lower binding energy of the interfacial CT states than that for the A excitons in WS$_2$ (~200 meV when it is covered by graphene) (52). Because of the spatially separated nature and the efficient screening of Coulomb interaction by graphene, electrons and holes generated at the interface from the CT states are more “free” and can potentially screen the Coulomb interaction more effectively than the A excitons, which result in a larger shift in the exciton resonance. Examination of the photoluminescence spectra reveals that the relative intensity of the trion emission to that of the neutral exciton is higher in the 1L-WS$_2$/G heterostructure than in the control WS$_2$ (fig. S12), consistent with the higher density of free carriers.

**Potential to extract carriers generated by the CT states**

The lifetime of the charge-separated states at the graphene-WS$_2$ interface has been measured to be ~1 ps (Fig. 2F). Although the charge-separated states live relatively short, the high carrier mobility of graphene on WS$_2$ makes it very promising to harvest these charge carriers. For instance, an electron mobility of 38,000 cm$^2$ V$^{-1}$ s$^{-1}$ at room temperature has been measured for graphene on the WS$_2$ substrate (33), similar to that of graphene on hexagonal boron nitride. Ultrafast carrier extraction from graphene in as short as 50 fs has been demonstrated (54); therefore, the 1-ps lifetime should be sufficiently long. Although our measurements do not directly measure the electron-hole binding energy at the interface, successful charge extraction has been confirmed in graphene/WS$_2$ photodetector devices (13, 32), which is probably facilitated by a built-in field at the interface. Therefore, the binding energy of these interlayer states can be overcome to achieve extraction.

**CONCLUSION**

In summary, ultrafast microscopy in combination with first-principles calculation provides a comprehensive picture of carrier generation resulting from interlayer coupling in WS$_2$/graphene heterostructures. Interlayer CT transitions and hot carrier injection promote electrons from graphene to WS$_2$, allowing carrier generation by excitation of CT transitions below the WS$_2$ bandgap and leading to enhancement in photocarrier generation by visible optical excitation. The CT transition energies predicted by first-principles calculations have been verified by experimental measurements. Broadband enhancement in carrier generation is highly attractive for photovoltaic applications of heterostructures based on graphene and 2D semiconductors.

**MATERIALS AND METHODS**

**Heterostructure fabrication**

1L- and 2L-WS$_2$ were mechanically exfoliated from bulk WS$_2$ crystals (2D Semiconductors Inc.) onto the Si wafer with a 90-nm-thick oxide. The number of layers was confirmed by using a combination of photoluminescence and Raman spectroscopy (55). Monolayer graphene film was grown on copper (Cu) foils at atmospheric pressure using CVD (56). The CVD-grown graphene used in this work was polycrystalline with an average grain size of ~15 μm. The heterostructures were assembled by depositing CVD-grown graphene on top of 1L- and 2L-WS$_2$ using an alternative poly(methyl methacrylate) (PMMA) transfer process to minimize aqueous solution at the graphene-WS$_2$ interface (57, 58). The CVD-grown graphene on Cu foil was spin-coated (3000 rpm) with 950PMMA-A4 (MicroChem). PMMA-coated graphene was adhered to a polymer frame with a hole at the center and suspended by Cu etching. Residual etchant was diluted with deionized water. The PMMA/graphene membrane was gently blown dry with nitrogen and then brought into contact with WS$_2$ layers followed by baking at around 350 K for 5 min to promote adhesion between graphene and WS$_2$. Finally, the heterostructure was annealed at 420 K in vacuum of 10$^{-5}$ torr for 2 hours followed by natural cooling. The orientation of WS$_2$ and graphene layers is not aligned in any particular way in the momentum space.

**Transient absorption microscopy and spectroscopy**

Transient absorption measurements were taken using a homebuilt TAM system performed in reflection mode, as shown schematically in fig. S2. Briefly, a Ti:sapphire oscillator (Coherent Mira 900) pumped by a Verdi diode laser (Verdi V18) was used as the light source (output at 790 nm, repetition rate of 80 MHz). Seventy percent of the pulse energy was fed into the optical parametric oscillator (Coherent Mira OPO) to generate probe light between 610 and 640 nm, whereas the remaining 30% was doubled to 395 nm using a β-barium borate crystal. The pump beam was modulated at 1 MHz using an acoustic optical modulator (R21080-1DM, Gooch & Housego). A 40× objective [numerical aperture (NA) = 0.60] was used to focus both pump and probe beams onto the sample, and the reflection light was then collected by the same objective and detected by an avalanche Si photodiode (Hamamatsu). The change in the probe reflection (AR) induced by the pump was detected by a lock-in amplifier (HF2LI, Zurich Instrument). For transient dynamics scans, pump and probe beams were overlapped.
spatially and a mechanical translation stage (Thorlabs, LTS300) was used to delay the probe with respect to the pump. For morphological TAM imaging, pump and probe beams were overlapped spatially and a piezoelectric stage (P-527.3CL, Physik Instrumente) with a step size of 100 nm was used to scan the sample. For the reflectance contrast measurements, the pump beam was blocked and only the reflection signal of the probe beam was detected. Transient absorption spectrum is defined as $\Delta R/R_0$, where $AR$ and $R_0$ are the change in the probe reflection induced by the pump and the probe reflection from the area without the sample, respectively.

For the measurement with tunable pump photon energy (Fig. 2A), the output of a high-repetition rate amplifier (Pharos Light Conversion, 400 kHz, 1030 nm) pumped two independent optical parametric amplifiers (OPAs), one providing the pump (between 1.2 and 1.8 eV) and the other supplying the probe (1.99 eV). Both the pump and probe beams were spatially filtered. An acousto-optic modulator (Gooch & Housego, R23080-1) was used to modulate the pump beam at 100 kHz. The change in the probe reflection ($\Delta R$) induced by the pump was detected by a lock-in amplifier (Stanford Research Instrument). All optical measurements were performed under ambient conditions.

### Linear absorption microscopy

We doubled the fundamental light (1.57 eV) from a Ti:sapphire oscillator (Coherent Mira 900) to measure the linear absorption at 3.14 eV of CVD-WS$_2$/G on a transparent sapphire substrate. A 40× objective (Coherent Mira 900) was used to measure the linear absorption at 3.14 eV of WS$_2$/G. The change in the probe reflection ($\Delta R$) induced by the pump was detected by a lock-in amplifier (Stanford Research Instrument). All optical measurements were performed under ambient conditions.

### Atomic force microscopy

The surface morphology of the heterostructure was inspected using an NT-MDT NTEGRA Prima multifunctional AFM in the tapping mode.

### First-principles calculations

All systems were fully optimized (atomic positions and lattice vectors) within DFT. In the commensurate model, we averaged the lattice vectors of graphene and WS$_2$ using $5 \times 5$ and $4 \times 4$ unit cells, respectively. This results in the lattice parameter $a = 12.433\,\text{Å}$, corresponding to 0.6% stretch of graphene and 1.7% compression of WS$_2$. In the incommensurate model, we superposed the band structure of perfect monolayers of graphene and WS$_2$ for the presentation of the band structure and the mismatch of the Brillouin zones of both materials. The models were fully optimized using CRYSTAL09 (60) with the following basis sets: C 6-21G* (61), S 86-311G* (62), W large-core effective core potential (ECP) (63), and the Perdew-Burke-Ernzerhof (PBE) functional (64) with the D3 dispersion correction proposed by Grimme (65). Band structures were obtained from the Vienna Ab initio Simulation Package (VASP) (66–68) using projector-augmented waves with energy cutoffs of 500 eV for the commensurate model and 600 eV for the unit cells. We used the HSE06 functional (69) together with the spin-orbit coupling for the incommensurate band structure representation, whereas the commensurate system was treated using PBE. The layered models were calculated with a 20 Å vacuum to ensure negligible interactions with the neighboring cells in the 3D periodic boundary condition representation. The dispersion corrections were treated at the D3 level. K-point meshes of $3 \times 3 \times 1$ and $6 \times 6 \times 1$ were used for the larger and smaller models, respectively.

### REFERENCES AND NOTES


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